Search Notes				

Application/Control No.	Applicant(s)/Patent under Reexamination
10/664,266	HANAI ET AL.
Examiner	Art Unit
Joseph D. Pape	3612

	SEARCHED				
Class	Subclass	Date	Examiner		
293	120 121 122 123 133 132	9/5/2005	JDP		
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INT	INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner		
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
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